

## KCX9860A-VB Datasheet

# N-Channel 600 V (D-S) Super Junction Power MOSFET

| PRODUCT SUMMARY                            |                        |      |  |  |
|--|------------------------|------|--|--|
| V <sub>DS</sub> (V) at T <sub>J</sub> max. | 600                    |      |  |  |
| R <sub>DS(on)</sub> at 25 °C (Ω)           | V <sub>GS</sub> = 10 V | 0.07 |  |  |
| Q <sub>g</sub> max. (nC)                   | 263                    |      |  |  |
| Q <sub>gs</sub> (nC)                       | 41                     |      |  |  |
| Q <sub>gd</sub> (nC)                       | 72                     |      |  |  |
| Configuration                              | Single                 |      |  |  |

#### **FEATURES**

- Low figure-of-merit (FOM) Ron x Qa
- Low input capacitance (Ciss)
- Reduced switching and conduction losses
- Ultra low gate charge (Qq)
- Avalanche energy rated (UIS)



#### **APPLICATIONS**

- Server and telecom power supplies
- Switch mode power supplies (SMPS)
- Power factor correction power supplies (PFC)
- Lighting
  - High-intensity discharge (HID)
  - Fluorescent ballast lighting
- Industrial
  - Welding
  - Induction heating
  - Motor drives
  - Battery chargers
  - Renewable energy
  - Solar (PV inverters)

| TO-247AC | 9   |
|----------|-----|
| G D S    | G S |
|          |     |

N-Channel MOSFET

| <b>ABSOLUTE MAXIMUM RATINGS</b> (T <sub>C</sub> = 25 °C, unless otherwise noted) |                         |   |                                   |             |        |  |
|--|-------------------------|---|-----------------------------------|-------------|--------|--|
| PARAMETER  |                         |   | SYMBOL                            | LIMIT       | UNIT   |  |
| Drain-Source Voltage   |                         |   | $V_{DS}$                          | 600         | .,,    |  |
| Gate-Source Voltage  |                         |   | $V_{GS}$                          | ± 30        | - V    |  |
| Continuous Drain Current (T <sub>J</sub> = 150 °C)                               | V <sub>GS</sub> at 10 V | $T_{\rm C} = 25  ^{\circ}{\rm C}$<br>$T_{\rm C} = 100  ^{\circ}{\rm C}$ | - I <sub>D</sub>                  | 46          | А      |  |
|  |                         | T <sub>C</sub> = 100 °C   |                                   | 29          |        |  |
| Pulsed Drain Current <sup>a</sup>  |                         |   | I <sub>DM</sub>                   | 139         |        |  |
| Linear Derating Factor   |                         |   |                                   | 3.3         | W/°C   |  |
| Single Pulse Avalanche Energy <sup>b</sup>                                       |                         |   | E <sub>AS</sub>                   | 1410        | mJ     |  |
| Maximum Power Dissipation  |                         |   | P <sub>D</sub>                    | 417         | W      |  |
| Operating Junction and Storage Temperature Range                                 |                         |   | T <sub>J</sub> , T <sub>stg</sub> | -55 to +150 | °C     |  |
| Drain-Source Voltage Slope   | T <sub>J</sub> = 125 °C |   | ط///ط÷                            | 37          | - V/ns |  |
| Reverse Diode dV/dt <sup>d</sup>   |                         |   | dV/dt                             | 9           | v/ns   |  |
| Soldering Recommendations (Peak Temperature) c                                   | for 10 s                |   |                                   | 300         | °C     |  |

#### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature.
- b.  $V_{DD}$  = 50 V, starting  $T_J$  = 25 °C, L = 28.2 mH,  $R_g$  = 25  $\Omega$ ,  $I_{AS}$  = 10 A.
- c. 1.6 mm from case.
- d.  $I_{SD} \le I_D$ , dI/dt = 100 A/ $\mu$ s, starting  $T_J = 25$  °C.



| THERMAL RESISTANCE RATINGS       |                   |      |      |      |  |  |
|----------------------------------|-------------------|------|------|------|--|--|
| PARAMETER                        | SYMBOL            | TYP. | MAX. | UNIT |  |  |
| Maximum Junction-to-Ambient      | R <sub>thJA</sub> | -    | 40   | °C/W |  |  |
| Maximum Junction-to-Case (Drain) | R <sub>thJC</sub> | -    | 0.3  |      |  |  |

| PARAMETER   | SYMBOL   | TES  | MIN.  | TYP.                        | MAX. | UNIT |      |       |    |
|---|--|--|---|-----------------------------|------|------|------|-------|----|
| Static  |  | -  |   |                             |      |      |      |       |    |
| Drain-Source Breakdown Voltage                            | $V_{DS}$                                       | $V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$  |   | 650                         | -    | -    | V    |       |    |
| V <sub>DS</sub> Temperature Coefficient                   | $\Delta V_{DS}/T_{J}$                          | Reference to 25 °C, I <sub>D</sub> = 1 mA  |   | =.                          | 0.70 |      | V/°C |       |    |
| Gate-Source Threshold Voltage (N)                         | V <sub>GS(th)</sub>                            | V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250 μA  |   | 2                           | -    | 4    | V    |       |    |
| Cata Carriaga Lagliaga                                    |  | V <sub>GS</sub> = ± 20 V   |   | $V_{GS} = \pm 20 \text{ V}$ |      | -    | -    | ± 100 | nA |
| Gate-Source Leakage                                       | I <sub>GSS</sub>                               |  | $V_{GS} = \pm 30 \text{ V}$   | -                           | -    | ± 1  | μΑ   |       |    |
| Zava Cata Valtaga Dvain Cuwant                            | $V_{DS} = 650 \text{ V}, V_{GS} = 0 \text{ V}$ |  | -   | -                           | 1    |      |      |       |    |
| Zero Gate Voltage Drain Current                           | I <sub>DSS</sub>                               | V <sub>DS</sub> = 520 \  | V <sub>DS</sub> = 520 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C |                             | -    | 25   | μA   |       |    |
| Drain-Source On-State Resistance                          | R <sub>DS(on)</sub>                            | V <sub>GS</sub> = 10 V   | I <sub>D</sub> = 24 A   | -                           | 0.07 | -    | Ω    |       |    |
| Forward Transconductance                                  | 9 <sub>fs</sub>                                | V <sub>DS</sub> = 30 V, I <sub>D</sub> = 24 A  |   | -                           | 16.7 | -    | S    |       |    |
| Dynamic   |  |  |   |                             |      |      |      |       |    |
| Input Capacitance   | C <sub>iss</sub>                               | V <sub>GS</sub> = 0 V,<br>V <sub>DS</sub> = 100 V,<br>f = 1 MHz                                      |   | -                           | 5182 | -    | pF   |       |    |
| Output Capacitance  | C <sub>oss</sub>                               |  |   | -                           | 251  | -    |      |       |    |
| Reverse Transfer Capacitance                              | C <sub>rss</sub>                               |  |   | -                           | 1    | -    |      |       |    |
| Effective Output Capacitance, Energy Related <sup>a</sup> | C <sub>o(er)</sub>                             | - V <sub>DS</sub> = 0 V to 520 V, V <sub>GS</sub> = 0 V  |   | -                           | 192  | -    |      |       |    |
| Effective Output Capacitance, Time Related <sup>b</sup>   | C <sub>o(tr)</sub>                             |  |   | -                           | 665  | -    |      |       |    |
| Total Gate Charge   | $Q_g$  |  |   | -                           | 172  | 263  |      |       |    |
| Gate-Source Charge  | Q <sub>gs</sub>                                | V <sub>GS</sub> = 10 V   | $V_{GS} = 10 \text{ V}$ $I_D = 24 \text{ A}, V_{DS} = 520 \text{ V}$    |                             | 41   | -    | nC   |       |    |
| Gate-Drain Charge   | Q <sub>gd</sub>                                | 1  |   |                             | 72   | -    |      |       |    |
| Turn-On Delay Time  | t <sub>d(on)</sub>                             | V <sub>DD</sub> = 520 V, I <sub>D</sub> = 6 A,   |   | -                           | 37   | 84   |      |       |    |
| Rise Time   | t <sub>r</sub>                                 |  |   | -                           | 77   | 121  |      |       |    |
| Turn-Off Delay Time                                       | t <sub>d(off)</sub>                            | V <sub>GS</sub> =  | $V_{GS} = 10 \text{ V}, R_g = 9.1 \Omega$                               |                             | 156  | 234  | ns   |       |    |
| Fall Time   | t <sub>f</sub>                                 | 1  |   | -                           | 93   | 196  |      |       |    |
| Gate Input Resistance                                     | R <sub>g</sub>                                 | f = 1 MHz, open drain  |   | -                           | 0.64 | -    | Ω    |       |    |
| <b>Drain-Source Body Diode Characteristic</b>             | s  |  |   |                             |      |      | •    |       |    |
| Continuous Source-Drain Diode Current                     | I <sub>S</sub>                                 | MOSFET symbol showing the integral reverse p - n junction diode                                      |   | -                           | -    | 47   |      |       |    |
| Pulsed Diode Forward Current                              | I <sub>SM</sub>                                |  |   | -                           | -    | 139  | A    |       |    |
| Diode Forward Voltage                                     | V <sub>SD</sub>                                | T <sub>J</sub> = 25 °C, I <sub>S</sub> = 24 A, V <sub>GS</sub> = 0 V                                 |   | -                           | 0.9  | 1.2  | V    |       |    |
| Reverse Recovery Time                                     | t <sub>rr</sub>                                | $T_J = 25 \text{ °C, } I_F = I_S = 24 \text{ A,}$<br>$dI/dt = 100 \text{ A/µs, } V_R = 25 \text{ V}$ |   | -                           | 753  | 1506 | ns   |       |    |
| Reverse Recovery Charge                                   | Q <sub>rr</sub>                                |  |   | -                           | 14   | 28   | μC   |       |    |
| Reverse Recovery Current                                  | I <sub>RRM</sub>                               |  |   | _                           | 28   | _    | A    |       |    |

#### Notes

- a.  $C_{oss(er)}$  is a fixed capacitance that gives the same energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DSS}$ . b.  $C_{oss(tr)}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DSS}$ .



### TYPCIAL CHARACTERISTICS (25 °C, unless otherwise noted)

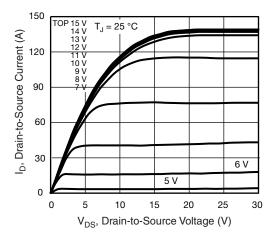


Fig. 1 - Typical Output Characteristics

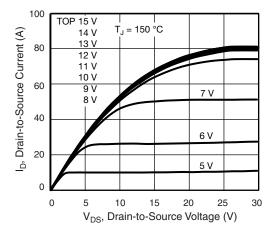


Fig. 2 - Typical Output Characteristics

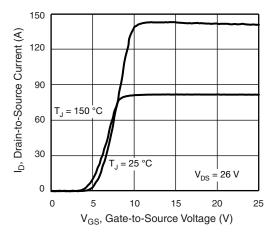


Fig. 3 - Typical Transfer Characteristics

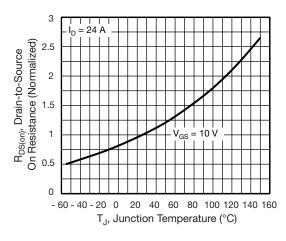


Fig. 4 - Normalized On-Resistance vs. Temperature

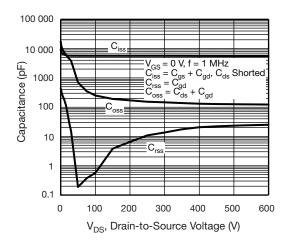


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

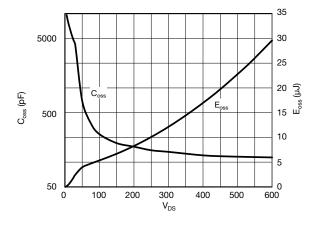


Fig. 6 -  $C_{oss}$  and  $E_{oss}$  vs.  $V_{DS}$ 



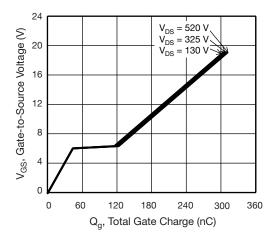


Fig. 7 - Typical Gate Charge vs. Gate-to-Source Voltage

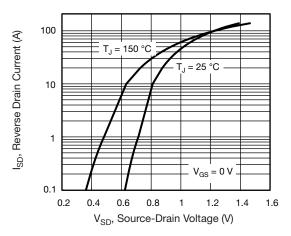


Fig. 8 - Typical Source-Drain Diode Forward Voltage

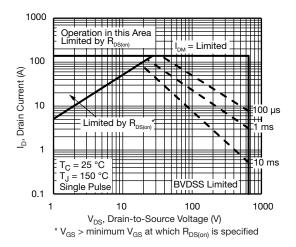


Fig. 9 - Maximum Safe Operating Area

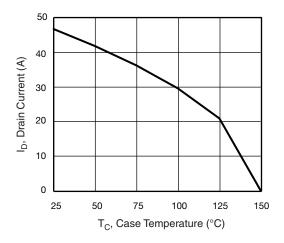


Fig. 10 - Maximum Drain Current vs. Case Temperature

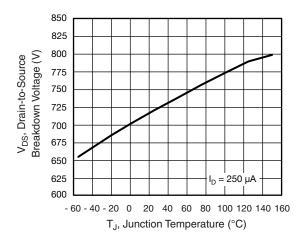


Fig. 11 - Temperature vs. Drain-to-Source Voltage



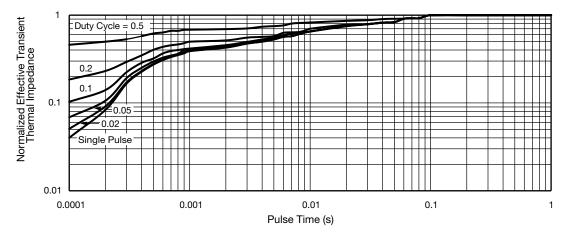


Fig. 12 - Normalized Thermal Transient Impedance, Junction-to-Case

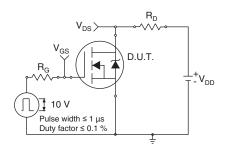


Fig. 13 - Switching Time Test Circuit

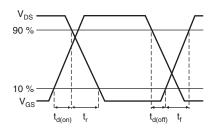


Fig. 14 - Switching Time Waveforms

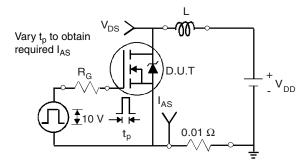


Fig. 15 - Unclamped Inductive Test Circuit

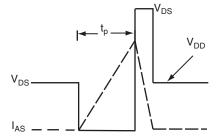


Fig. 16 - Unclamped Inductive Waveforms

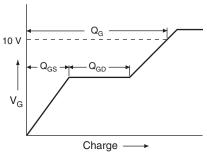


Fig. 17 - Basic Gate Charge Waveform

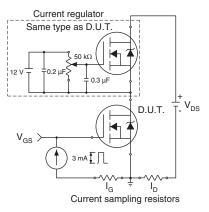
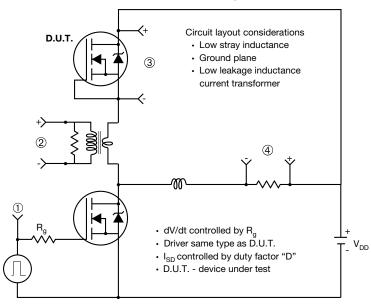


Fig. 18 - Gate Charge Test Circuit



## Peak Diode Recovery dV/dt Test Circuit



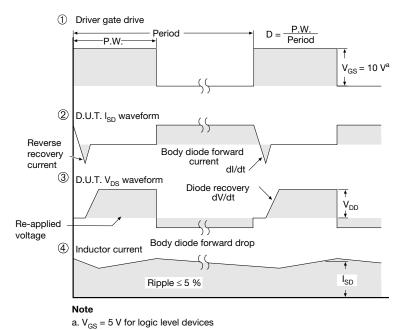


Fig. 19 - For N-Channel



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